



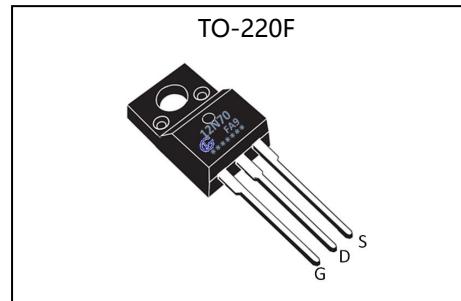
GL12N70FA9

Silicon N-Channel Power MOSFET

General Description

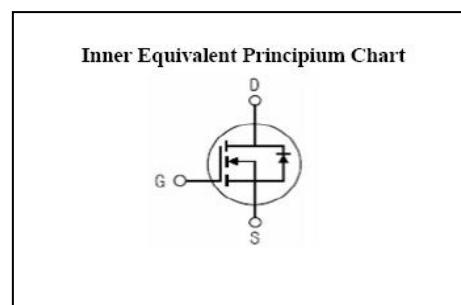
GL12N70FA9, the silicon N-channel Enhanced VDMOSFET, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is TO-220F, which accords with the RoHS standard.

V_{DSS}	700	V
I_D	12	A
$P_D(T_C=25^\circ\text{C})$	60	W
$R_{DS(\text{ON}),\text{TYP.}}$	0.55	Ω



Features

- Fast Switching
- Low ON Resistance($R_{ds(on)} \leq 0.65\Omega$)
- Low Gate Charge (Typical Data:46nC)
- Low Reverse transfer capacitances(Typical:23pF)
- 100% Single Pulse avalanche energy Test



Applications

- Power switch circuit of adaptor and charger

Absolute ($T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-to-Source Voltage	700	V
I_D	Continuous Drain Current	12	A
I_{DM}^{a1}	Pulsed Drain Current	48	A
V_{GS}	Gate-to-Source Voltage	± 30	V
E_{AS}^{a2}	Single Pulse Avalanche Energy	1000	mJ
dv/dt^{a3}	Peak Diode Recovery dv/dt	5.0	V/ns
P_D	Power Dissipation	60	W
	Derating Factor above 25°C	0.48	W/ $^\circ\text{C}$
T_J, T_{stg}	Operating Junction and Storage Temperature Range	150, -55 to 150	$^\circ\text{C}$
T_L	Maximum Temperature for Soldering	300	$^\circ\text{C}$

Caution Stresses greater than those in the "Absolute Maximum Ratings" may cause permanent damage to the device

Thermal Characteristics

Symbol	Parameter	Rating	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	2.08	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	100	$^\circ\text{C}/\text{W}$



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Electrical Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

OFF Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V_{DSS}	Drain to Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	700	--	--	V
$\Delta V_{DSS}/\Delta T_J$	Bvdss Temperature Coefficient	$I_D=250\mu\text{A}$, Reference 25°C	--	0.55	--	$\text{V}/^\circ\text{C}$
I_{DSS}	Drain to Source Leakage Current	$V_{DS}=700\text{V}, V_{GS}=0\text{V}, T_a=25^\circ\text{C}$	--	--	1.0	μA
		$V_{DS}=560\text{V}, V_{GS}=0\text{V}, T_a=125^\circ\text{C}$	--	--	100	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+30\text{V}$	--	--	100	nA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-30\text{V}$	--	--	-100	nA

ON Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=10\text{V}, I_D=6.0\text{A}$	--	0.55	0.65	Ω
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2.0	--	4.0	V
g_{fs}	Forward Trans conductance	$V_{DS}=30\text{V}, I_D=12\text{A}$	--	16	--	S
Pulse width < 380μs; duty cycle < 2%.						

Dynamic Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=25\text{V}$ $f=1.0\text{MHz}$	--	2120	2544	pF
C_{oss}	Output Capacitance		--	190	228	
C_{rss}	Reverse Transfer Capacitance		--	23	27	

Resistive Switching Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$I_D=12\text{A}, V_{DD}=350\text{V}$ $V_{GS}=10\text{V}, R_g=9.1\Omega$	--	17	--	ns
t_r	Rise Time		--	26	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	54	--	
t_f	Fall Time		--	38	--	
Q_g	Total Gate Charge	$I_D=12\text{A}, V_{DD}=350\text{V}$ $V_{GS}=10\text{V}$	--	46	56	nC
Q_{gs}	Gate to Source Charge		--	10	--	
Q_{gd}	Gate to Drain ("Miller")Charge		--	18	--	



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Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I _{SD}	Continuous Source Current (Body Diode)		--	--	12	A
I _{SM}	Maximum Pulsed Current (Body Diode)		--	--	48	A
V _{SD}	Diode Forward Voltage	I _S =12A, V _{GS} =0V	--	--	1.5	V
t _{rr}	Reverse Recovery Time	I _S =11A, T _j =25°C	--	--	570	ns
Q _{rr}	Reverse Recovery Charge	dI _F /dt=100A/μs, V _{GS} =0V	--	--	4.4	μC

a1: Repetitive rating; pulse width limited by maximum junction temperature

a2: L=10mH, I_D=12A, Start T_j=25°C

a3: I_{SD}=12A, di/dt ≤100A/μs, V_{DD}≤BV_{DS}, Start T_j=25°C

Characteristics Curves

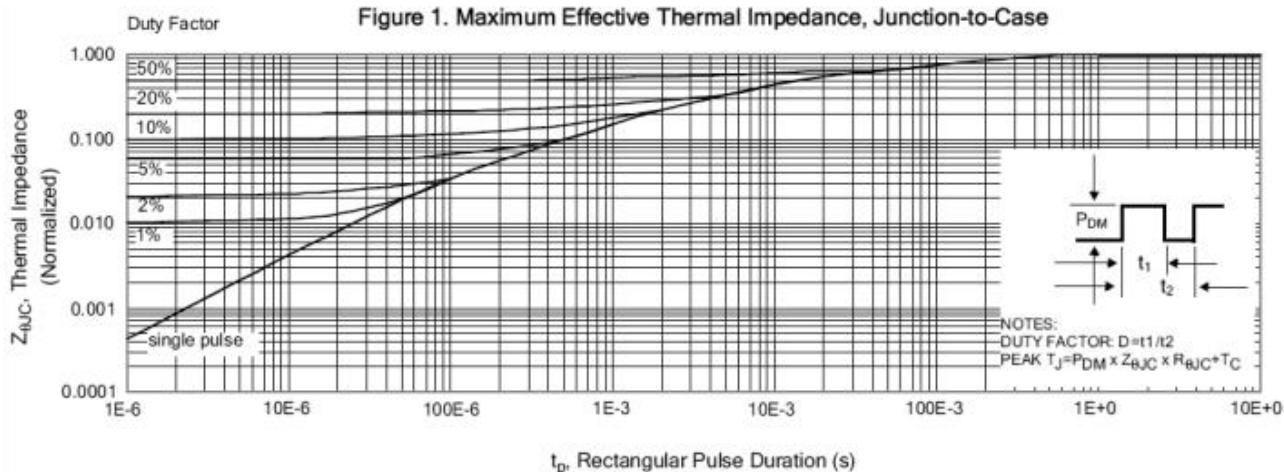


Figure 2. Maximum Power Dissipation vs Case Temperature

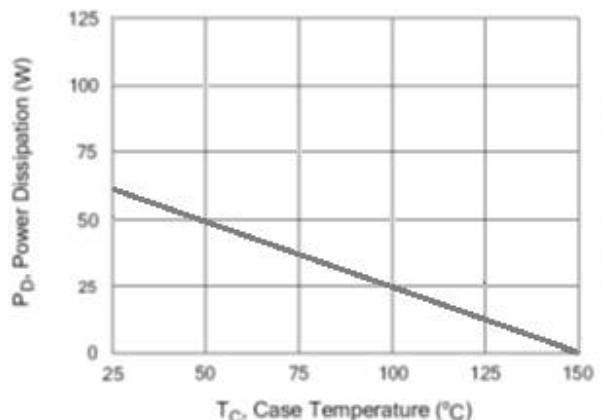


Figure 4. Typical Output Characteristics

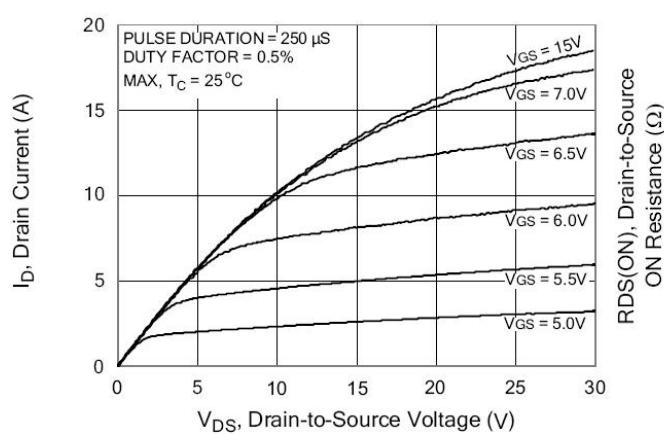


Figure 3. Maximum Continuous Drain Current vs Case Temperature

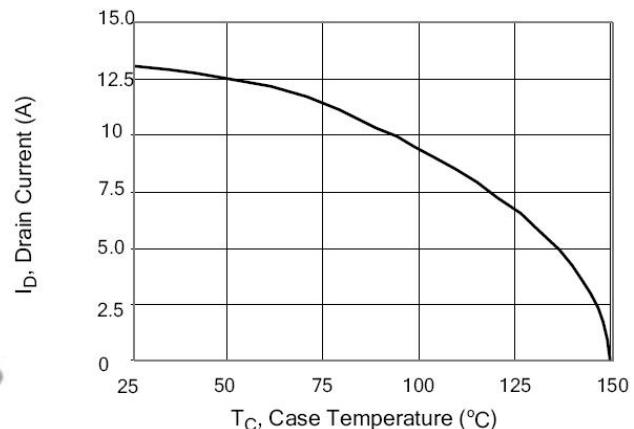
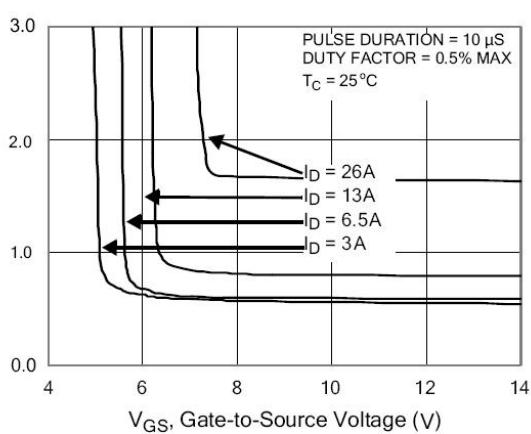


Figure 5. Typical Drain-to-Source ON Resistance vs Gate Voltage and Drain Current





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Figure 6. Maximum Peak Current Capability

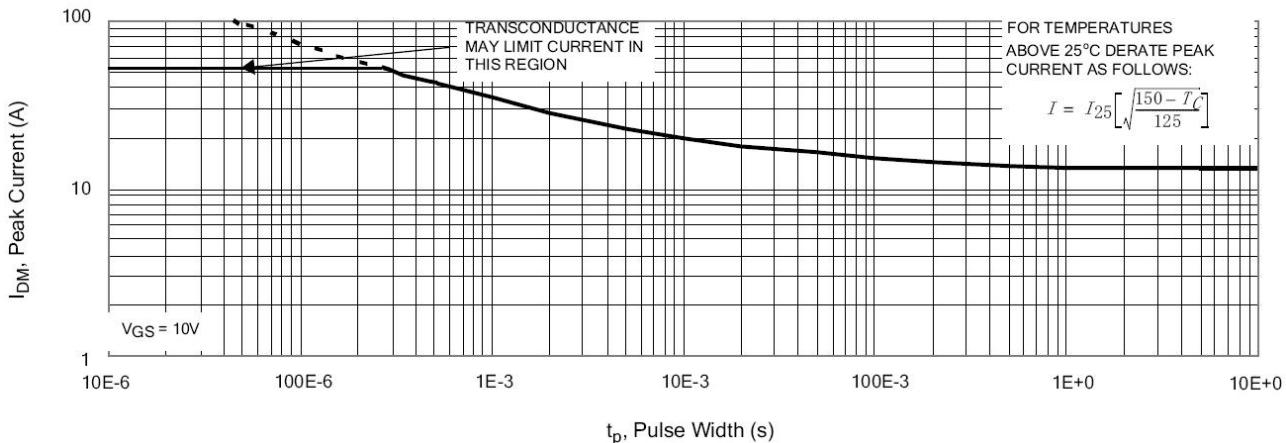


Figure 7. Typical Transfer Characteristics

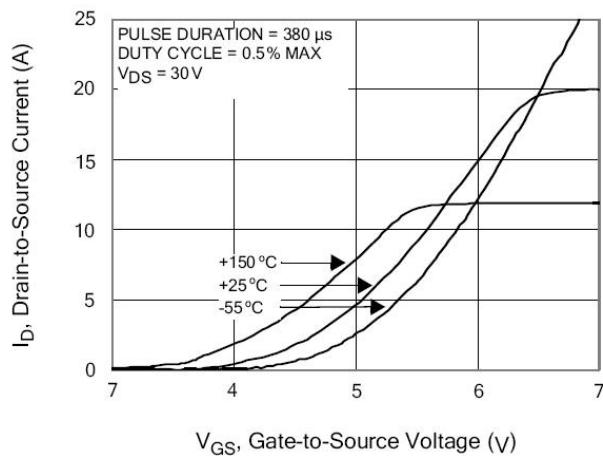


Figure 9. Typical Drain-to-Source ON Resistance vs Drain Current

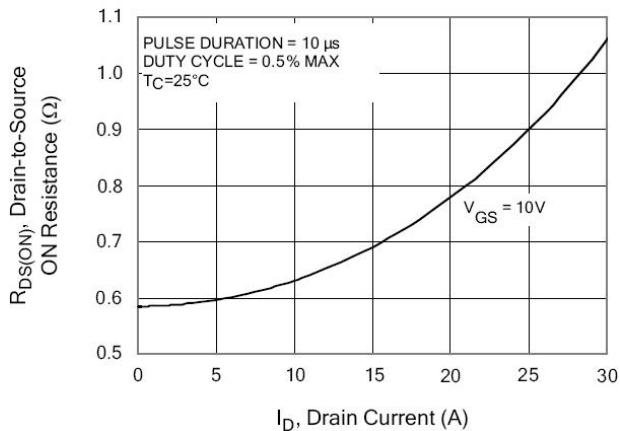


Figure 8. Unclamped Inductive Switching Capability

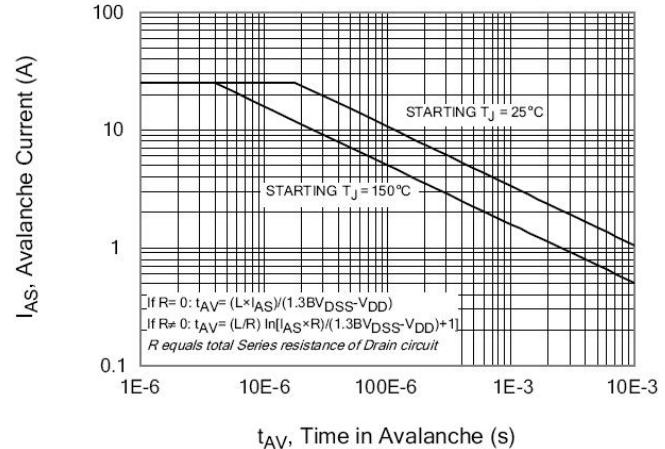
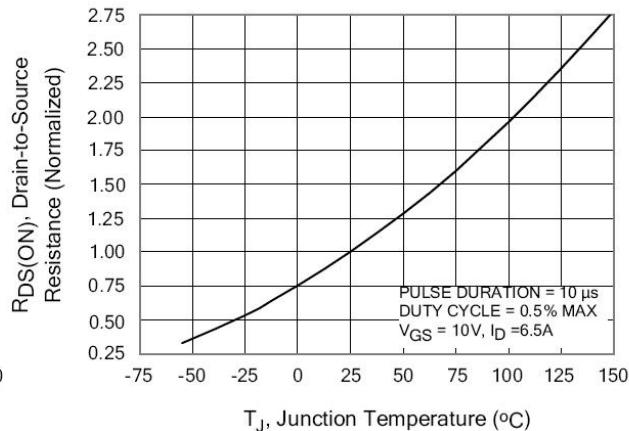


Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature





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Figure 11. Typical Breakdown Voltage vs Junction Temperature

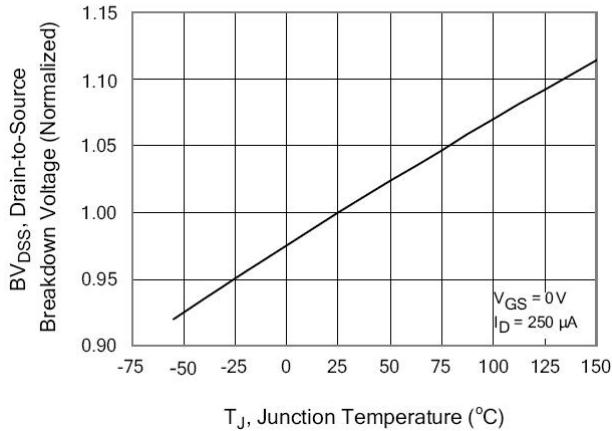


Figure 12. Typical Threshold Voltage vs Junction Temperature

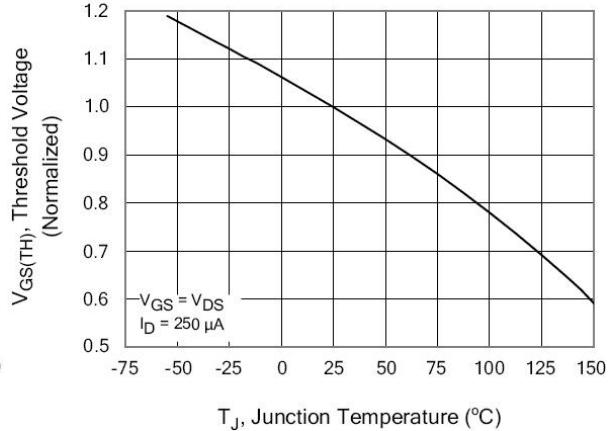


Figure 13. Maximum Forward Bias Safe Operating Area

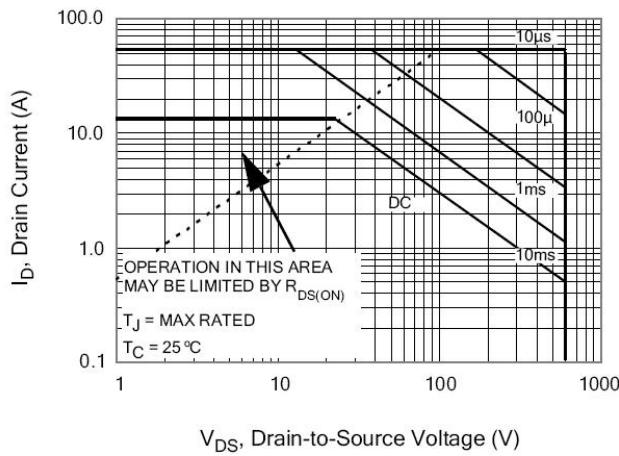


Figure 14. Typical Capacitance vs Drain-to-Source Voltage

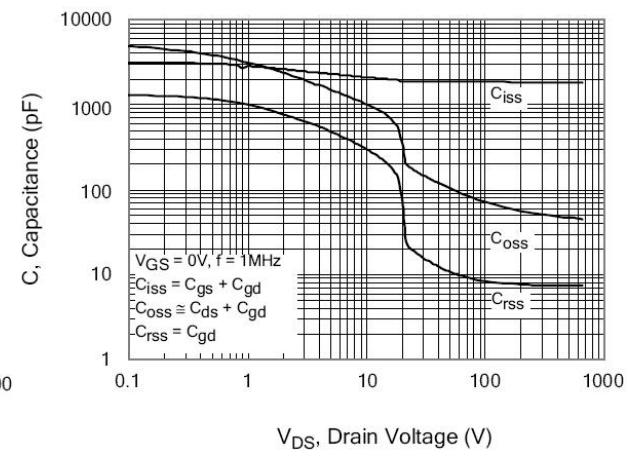


Figure 15. Typical Gate Charge vs Gate-to-Source Voltage

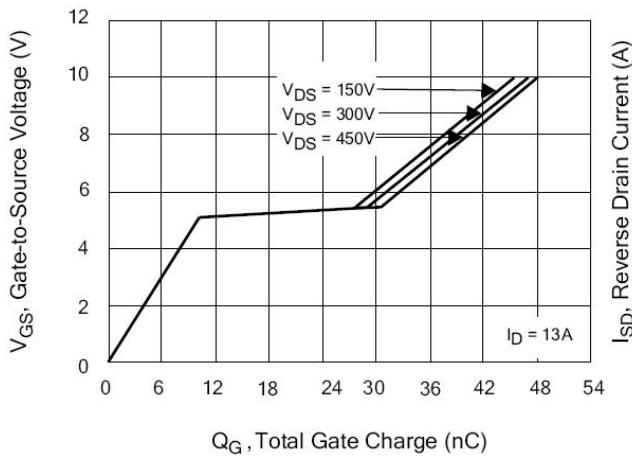


Figure 16. Typical Body Diode Transfer Characteristics

